Sea	arch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,419	FU ET AL.
Examiner	Art Unit
Tianjie Chen	2652

SEARCHED				
Class	Subclass	Date	Examiner	
360	264.7			
	264.8			
	264.9			
	265			
310	12		•	
	15	10/19/2005	TJ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
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